Search Notes

Application/Control No.	Applicant(s)/Patent unde Reexamination		
09/990,268	AMONOU ET AL.		
Examiner	Art Unit		
David Y. Jung	2134		

SEARCHED				
Class	Subclass	Date	Examiner	
726	21	11/26/2006	DJ	
713	176	11/26/2006	DJ	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH I (INCLUDING SEAR		')
	DATE	EXMR
look at previously searched subclasses of US Patents	11/26/2006	ĐJ
West, NPL, Internet	11/26/2006	DJ
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